

5-V Low-Drop Voltage Regulator

TLE 4267

Bipolar IC

Features

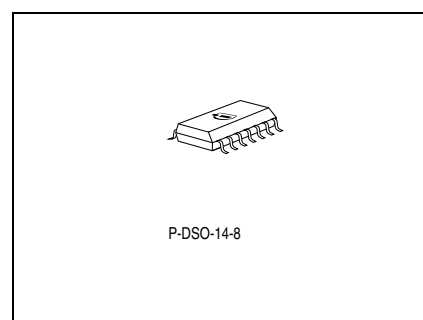
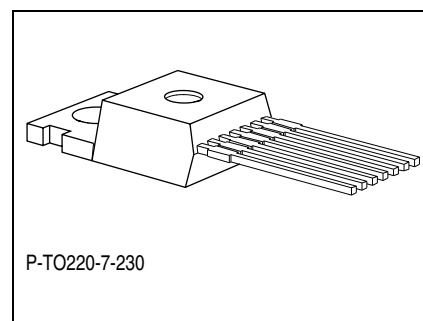
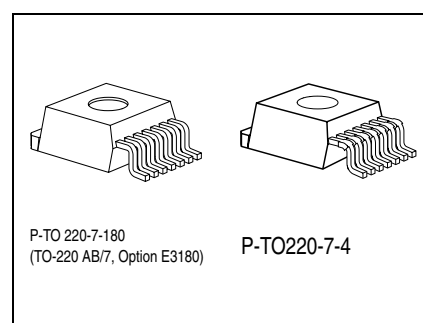
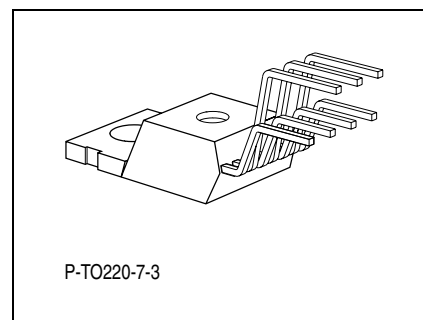
- Output voltage tolerance $\leq \pm 2 \%$
- 400 mA output current capability
- Low-drop voltage
- Very low standby current consumption
- Input voltage up to 40 V
- Overvoltage protection up to 60 V (≤ 400 ms)
- Reset function down to 1 V output voltage
- ESD protection up to 2000 V
- Adjustable reset time
- On/off logic
- Overtemperature protection
- Reverse polarity protection
- Short-circuit proof
- Wide temperature range
- Suitable for use in automotive electronics

Type	Ordering Code	Package
TLE 4267	Q67000-A9153	P-TO220-7-3 P-TO220-7-11
TLE 4267 G	Q67006-A9169	P-TO220-7-180 P-TO220-7-4
TLE 4267 S	Q67000-A9246	P-TO220-7-230 P-TO220-7-12
TLE 4267 GM	Q67006-A9398	P-DSO-14-8

■ SMD type

Functional Description

TLE 4267 is a 5-V low-drop voltage regulator for automotive applications in the TO220-7 or DSO-14 package. It supplies an output current of > 400 mA. The IC is shortcircuit-proof and has an overtemperature protection circuit.



Application

The IC regulates an input voltage V_i in the range of $5.5\text{ V} < V_i < 40\text{ V}$ to a nominal output voltage of $V_o = 5.0\text{ V}$. A reset signal is generated for an output voltage of $V_o < V_{RT}$ (typ. 4.5 V). The reset delay can be set with an external capacitor. The device has two logic inputs. A voltage of $V_{E2} > 4.0\text{ V}$ given to the E2-pin (e.g. by ignition) turns the device on. Depending on the voltage on pin E6 the IC may be hold in active-state even if V_{E2} goes to low level. This makes it simple to implement a self-holding circuit without external components. When the device is turned off, the output voltage drops to 0 V and current consumption tends towards $0\text{ }\mu\text{A}$.

Design Notes for External Components

The input capacitor C_i is necessary for compensation of line influences. The resonant circuit consisting of lead inductance and input capacitance can be damped by a resistor of approx. $1\text{ }\Omega$ in series with C_i . The output capacitor is necessary for the stability of the regulating circuit. Stability is guaranteed at values of $\geq 22\text{ }\mu\text{F}$ and an ESR of $\leq 3\text{ }\Omega$ within the operating temperature range.

Circuit Description

The control amplifier compares a reference voltage, which is kept highly accurate by resistance adjustment, to a voltage that is proportional to the output voltage and drives the base of the series transistor via a buffer. Saturation control as a function of the load current prevents any over-saturating of the power element.

The reset output RO is in high-state if the voltage on the delay capacitor C_D is greater or equal V_{UD} . The delay capacitance C_D is charged with the current I_D for output voltages greater than the reset threshold V_{RT} . If the output voltage gets lower than V_{RT} a fast discharge of the delay capacitor C_D sets in and as soon as V_{CD} gets lower than V_{LD} the reset output RO is set to low-level (see **Figure 6**). The reset delay can be set within wide range by dimensioning the capacitance of the external capacitor.

Truth Table for Turn-ON/Turn-OFF Logic

E2, Inhibit	E6, Hold	V_Q	Remarks
L	X	OFF	Initial state, Inhibit internally pulled up
H	X	ON	Regulator switched on via Inhibit, by ignition for example
H	L	ON	Hold clamped active to ground by controller while Inhibit is still high
X	L	ON	Previous state remains, even ignition is shut off: self-holding state
L	L	ON	Ignition shut off while regulator is in self-holding state
L	H	OFF	Regulator shut down by releasing of Hold while Inhibit remains Low, final state. No active clamping required by external self-holding circuit (μ C) to keep regulator in off-state.

Inhibit: E2 Enable function, active High

Hold: E6 Hold and release function, active Low

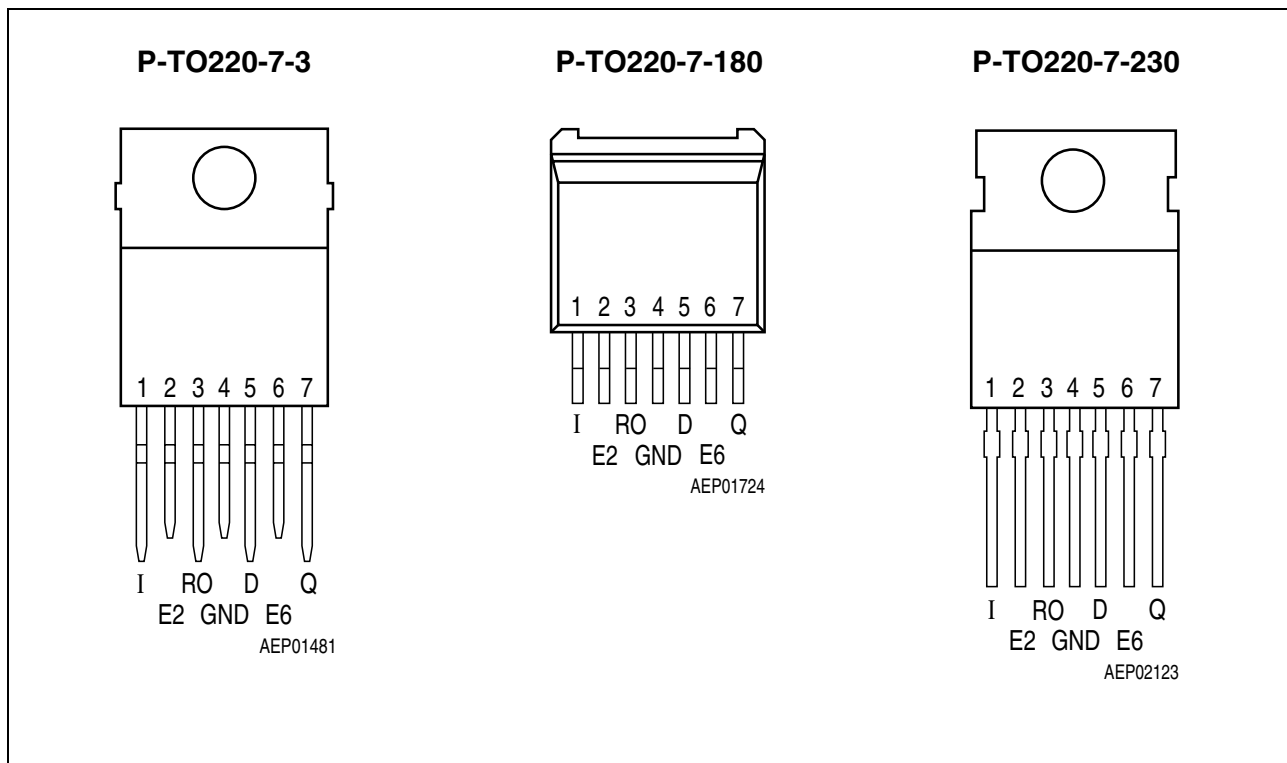


Figure 1 Pin Configuration (top view)

Pin Definitions and Functions

Pin	Symbol	Function
1	I	Input; block to ground directly at the IC by a ceramic capacitor
2	E2	Inhibit; device is turned on by High signal on this pin; internal pulldown resistor of 100 k Ω
3	RO	Reset Output; open-collector output internally connected to the output via a resistor of 30 k Ω
4	GND	Ground; connected to rear of chip
5	D	Reset Delay; connect via capacitor to GND
6	E6	Hold; see truth table above for function; this input is connected to output voltage via a pull up resistor of 50 k Ω
7	Q	5-V Output; block to GND with 22- μ F capacitor, ESR < 3 Ω

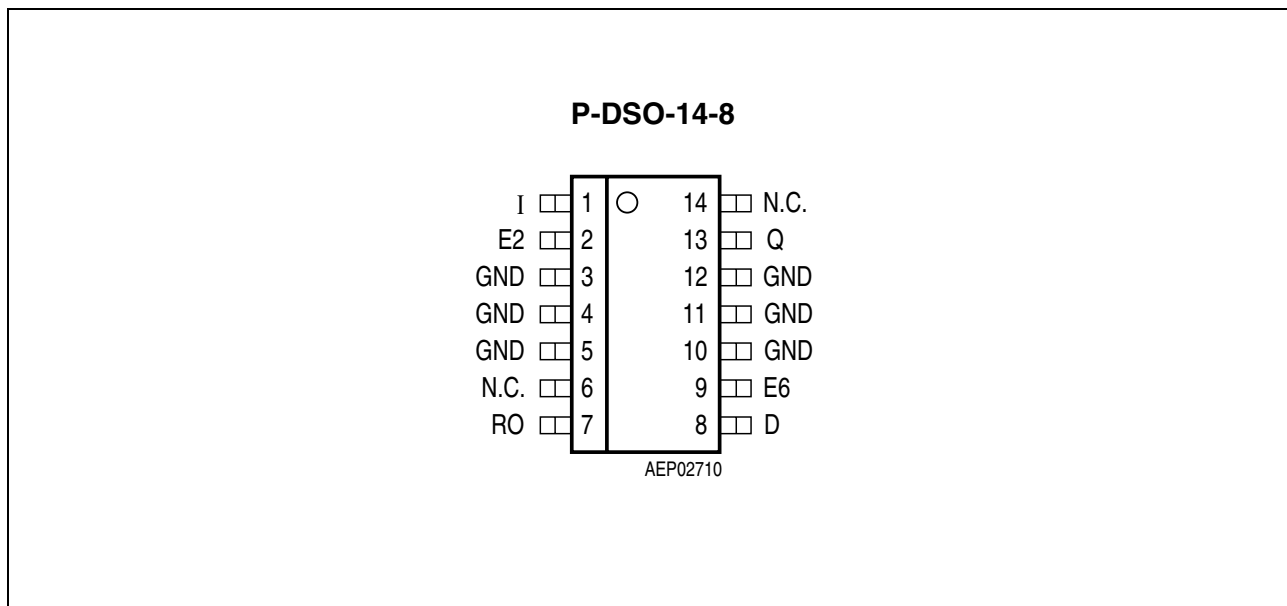


Figure 2 Pin Configuration (top view) (cont'd)

Pin Definitions and Functions

Pin	Symbol	Function
1	I	Input; block to ground directly at the IC by a ceramic capacitor
2	E2	Inhibit; device is turned on by High signal on this pin; internal pulldown resistor of 100 k Ω
7	RO	Reset Output; open-collector output internally connected to the output via a resistor of 30 k Ω
3, 4, 5, 10, 11, 12	GND	Ground; connected to rear of chip
8	D	Reset Delay; connect with capacitor to GND for setting delay
9	E6	Hold; see truth table above for function; this input is connected to output voltage via a pull up resistor of 50 k Ω
13	Q	5-V Output; block to GND with 22- μ F capacitor, ESR $\leq$ 3 Ω
6, 14	N.C.	Not Connected

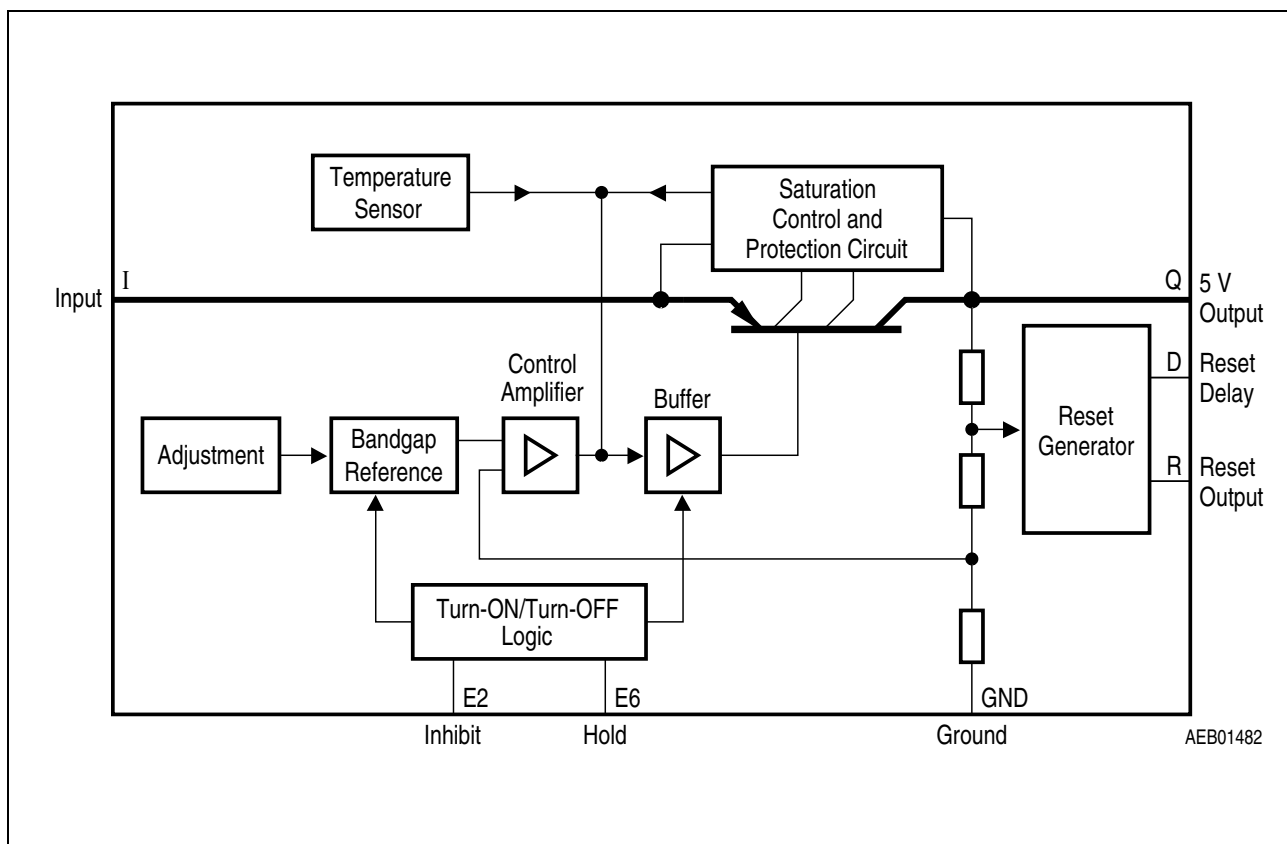


Figure 3 Block Diagram

Absolute Maximum Ratings
 $T_J = -40 \text{ to } 150 \text{ }^{\circ}\text{C}$

Parameter	Symbol	Limit Values		Unit	Notes
		min.	max.		

Input

Voltage	V_I	- 42	42	V	–
Voltage	V_I	–	60	V	$t \leq 400 \text{ ms}$
Current	I_I	–	–	–	internally limited

Reset Output

Voltage	V_{RO}	- 0.3	7	V	–
Current	I_{RO}	–	–	–	internally limited

Reset Delay

Voltage	V_D	- 0.3	42	V	–
Current	I_D	–	–	–	–

Output

Voltage	V_Q	- 0.3	7	V	–
Current	I_Q	–	–	–	internally limited

Inhibit

Voltage	V_{E2}	- 42	42	V	–
Current	I_{E2}	- 5	5	mA	$t \leq 400 \text{ ms}$

Hold

Voltage	V_{E6}	- 0.3	7	V	–
Current	I_{E6}	–	–	mA	internally limited

GND

Current	I_{GND}	- 0.5	–	A	–
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Temperatures

Junction temperature	T_J	–	150	$^{\circ}\text{C}$	–
Storage temperature	T_{stg}	- 50	150	$^{\circ}\text{C}$	–

Operating Range

Parameter	Symbol	Limit Values		Unit	Notes
		min.	max.		
Input voltage	V_I	5.5	40	V	see diagram
Junction temperature	T_J	– 40	150	°C	–

Thermal Resistance

Junction ambient	R_{thja}	–	65	K/W	P-TO220-7-3 package
Junction-case	R_{thjc}	–	6	K/W	P-TO220-7-3 package
Junction-case	Z_{thjc}	–	2	K/W	$T < 1$ ms P-TO220-7-3 package
Junction ambient	R_{thja}	–	70	K/W	P-TO220-7-180 (SMD) package
Junction-case	R_{thjc}	–	6	K/W	P-TO220-7-180 (SMD) package
Junction-case	Z_{thjc}	–	2	K/W	$T < 1$ ms P-TO220-7-180 (SMD) package
Junction ambient	R_{thja}	–	65	K/W	P-TO220-7-230 package
Junction-case	R_{thjc}	–	6	K/W	P-TO220-7-230 package
Junction-case	Z_{thjc}	–	2	K/W	$T < 1$ ms P-TO220-7-230 package
Junction ambient	R_{thja}	–	70	K/W	P-DSO-14-8 package
Junction-pin	R_{thjp}	–	30	K/W	P-DSO-14-8 package

Characteristics

$V_I = 13.5 \text{ V}$; $-40 \text{ }^\circ\text{C} < T_J < 125 \text{ }^\circ\text{C}$; $V_{E2} > 4 \text{ V}$ (unless specified otherwise)

Parameter	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		
Output voltage	V_Q	4.9	5	5.1	V	$5 \text{ mA} \leq I_Q \leq 400 \text{ mA}$ $6 \text{ V} \leq V_I \leq 26 \text{ V}$
Output voltage	V_Q	4.9	5	5.1	V	$5 \text{ mA} \leq I_Q \leq 150 \text{ mA}$ $6 \text{ V} \leq V_I \leq 40 \text{ V}$
Output current limiting	I_Q	500	–	–	mA	$T_J = 25 \text{ }^\circ\text{C}$
Current consumption $I_q = I_I - I_Q$	I_q	–	–	50	μA	IC turned off
Current consumption $I_q = I_I - I_Q$	I_q	–	1.0	10	μA	$T_J = 25 \text{ }^\circ\text{C}$ IC turned off
Current consumption $I_q = I_I - I_Q$	I_q	–	1.3	4	mA	$I_Q = 5 \text{ mA}$ IC turned on
Current consumption $I_q = I_I - I_Q$	I_q	–	–	60	mA	$I_Q = 400 \text{ mA}$
Current consumption $I_q = I_I - I_Q$	I_q	–	–	80	mA	$I_Q = 400 \text{ mA}$ $V_I = 5 \text{ V}$
Drop voltage	V_{Dr}	–	0.3	0.6	V	$I_Q = 400 \text{ mA}^{1)}$
Load regulation	ΔV_Q	–	–	50	mV	$5 \text{ mA} \leq I_Q \leq 400 \text{ mA}$
Supply-voltage regulation	ΔV_Q	–	15	25	mV	$V_I = 6 \text{ to } 36 \text{ V}$; $I_Q = 5 \text{ mA}$
Supply-voltage rejection	SVR	–	54	–	dB	$f_r = 100 \text{ Hz}$; $V_r = 0.5 \text{ V}_{pp}$
Longterm stability	ΔV_Q	–	0	–	mV	1000 h

¹⁾ Drop voltage = $V_I - V_Q$ (measured when the output voltage V_Q has dropped 100 mV from the nominal value obtained at $V_I = 13.5 \text{ V}$)

Characteristics (cont'd)

Parameter	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		

Reset Generator

Switching threshold	V_{RT}	4.2	4.5	4.8	V	—
Reset High level	—	4.5	—	—	V	$R_{ext} = \infty$
Saturation voltage	$V_{RO,SAT}$	—	0.1	0.4	V	$R_R = 4.7 \text{ k}\Omega$ ¹⁾
Internal Pull up resistor	R_{RO}	—	30	—	k Ω	—
Saturation voltage	$V_{D,SAT}$	—	50	100	mV	$V_Q < V_{RT}$
Charge current	I_D	8	15	25	μA	$V_D = 1.5 \text{ V}$
Upper delay switching threshold	V_{UD}	2.6	3	3.3	V	—
Delay time	t_D	—	20	—	ms	$C_d = 100 \text{ nF}$
Lower delay switching threshold	V_{LD}	—	0.43	—	V	—
Reset reaction time	t_{RR}	—	2	—	μs	$C_d = 100 \text{ nF}$

Inhibit

Turn on voltage	$V_{U,INH}$	—	3	4	V	IC turned on
Turn off voltage	$V_{L,INH}$	2	—	—	V	IC turned off
Pull down resistor	R_{INH}	50	100	200	k Ω	—
Hysteresis	ΔV_{INH}	0.2	0.5	0.8	V	—
Input current	I_{INH}	—	35	100	μA	$V_{INH} = 4 \text{ V}$
Hold voltage	$V_{U,HOLD}$	30	35	40	%	Referred to V_Q
Turn off voltage	$V_{L,HOLD}$	60	70	80	%	Referred to V_Q
Pull up resistor	R_{HOLD}	20	50	100	k Ω	—

Overvoltage Protection

Turn off voltage	$V_{I,OV}$	42	44	46	V	—
Turn on hysteresis	$\Delta V_{I,OV}$	2	—	6	V	—

¹⁾ The reset output is Low for $1 \text{ V} < V_Q < V_{RT}$

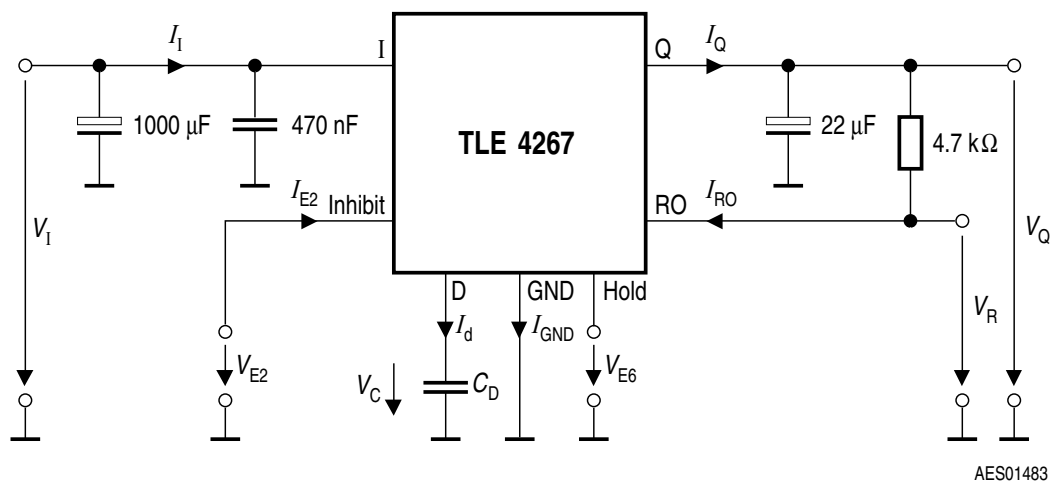


Figure 4 Test Circuit

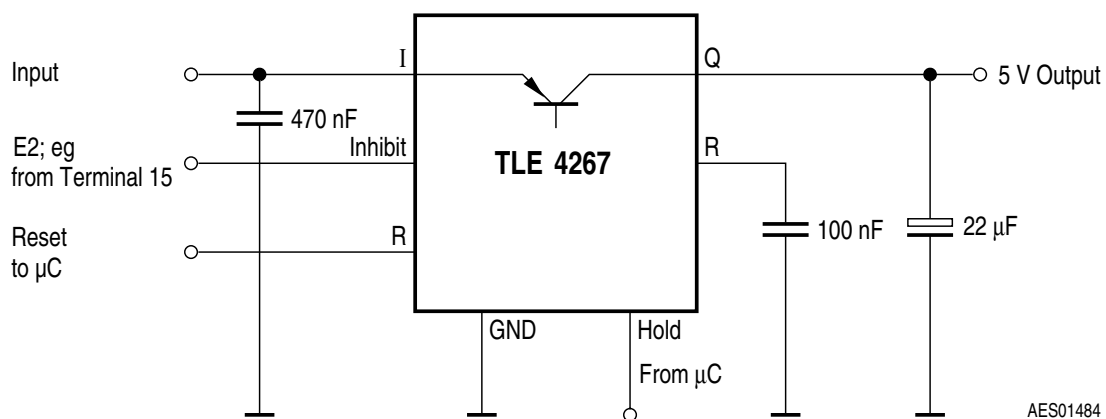


Figure 5 Application Circuit

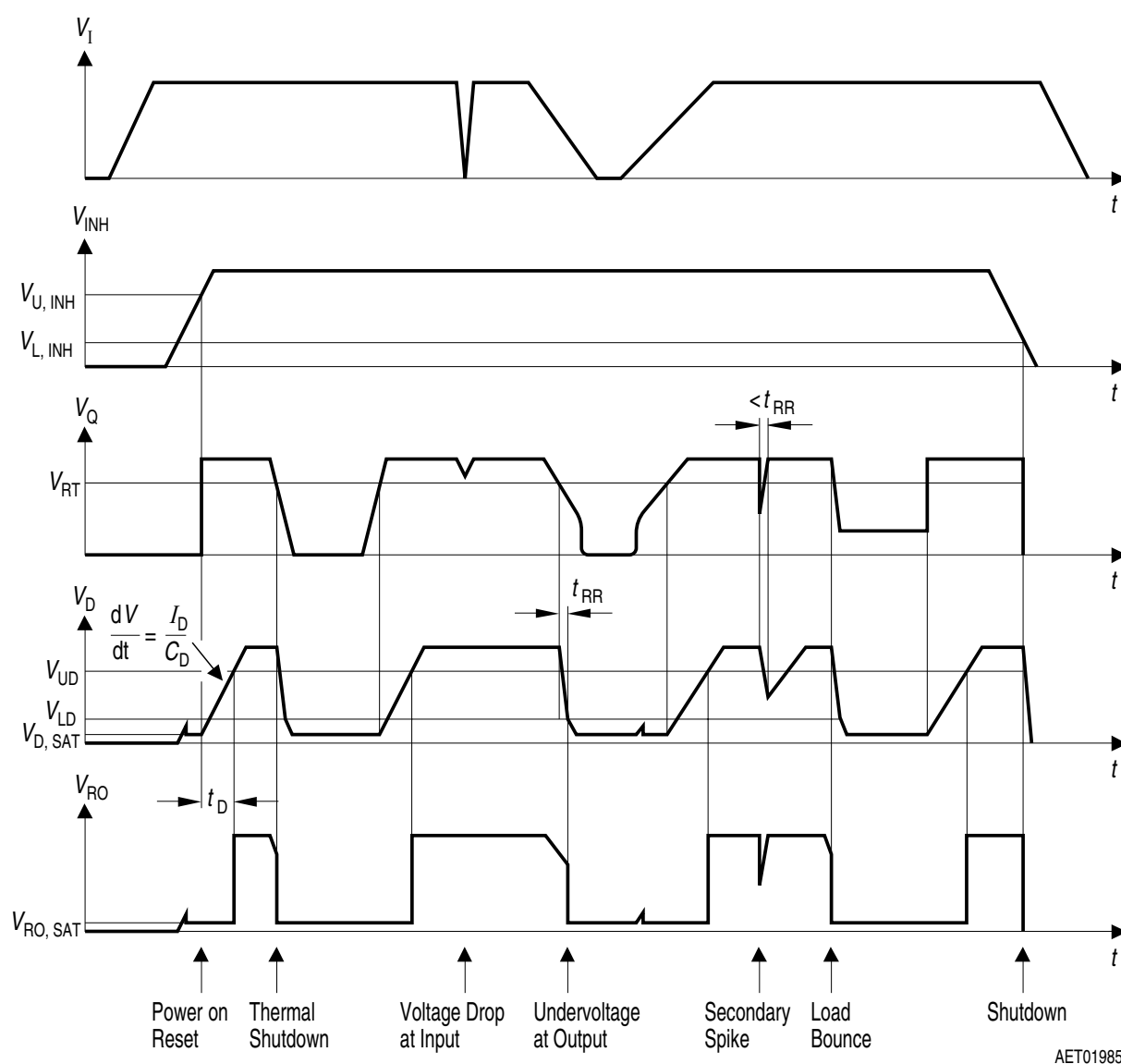
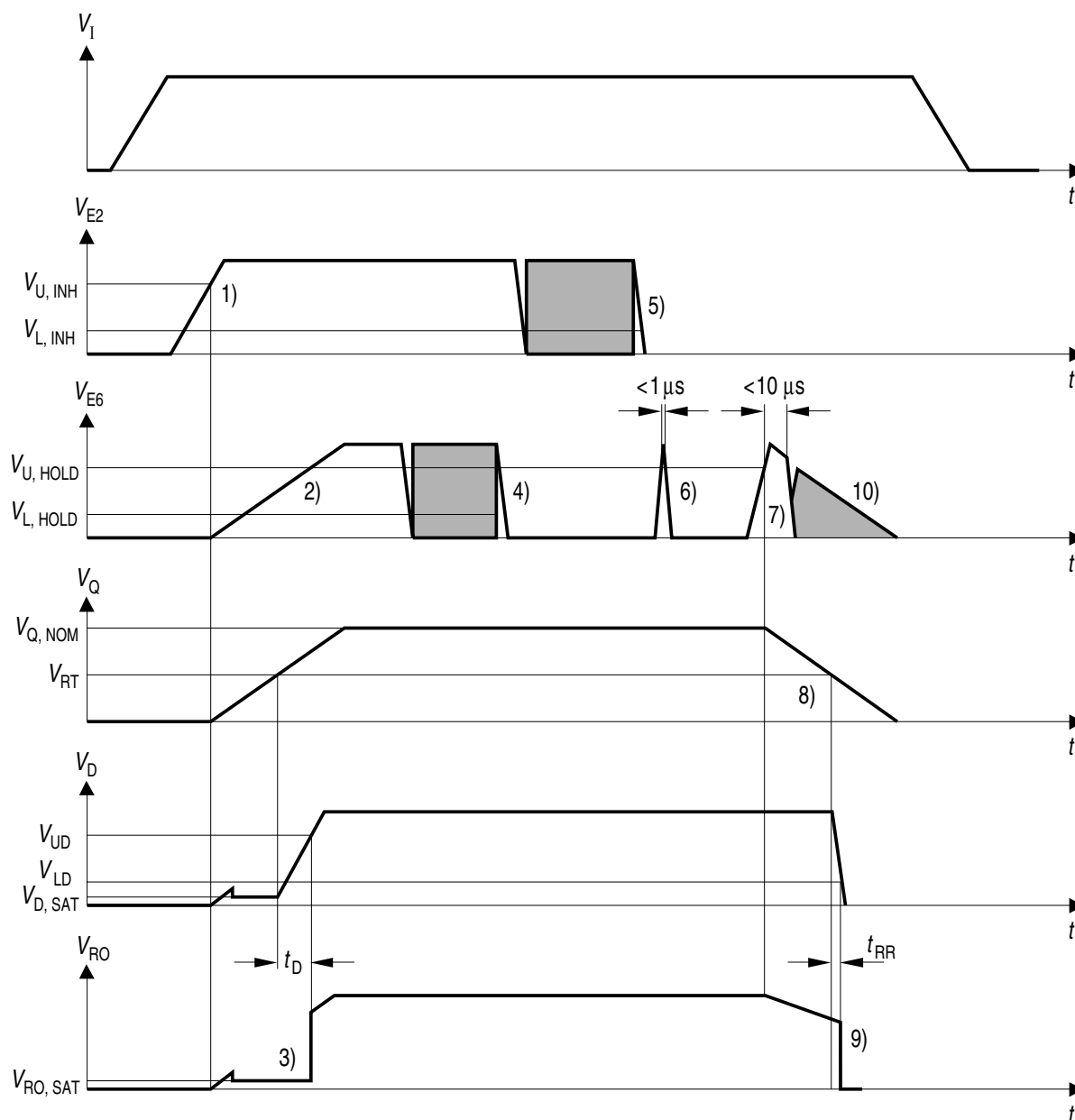


Figure 6 Time Response

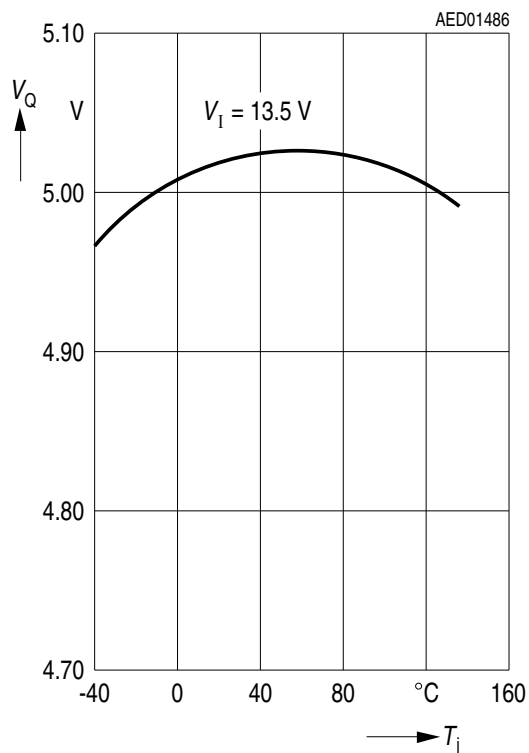


- | | |
|--|--|
| 1) Enable active | 6) Pulse width smaller than 1 μ s |
| 2) Hold inactive, pulled up by V_Q | 7) Hold inactive, released by μ C |
| 3) Power-ON reset | 8) Voltage controller shutdown |
| 4) Hold active, clamped to GND by external μ C | 9) Output-low reset |
| 5) Enable inactive, clamped by int. pull-down resistor | 10) No switch on via V_{E6} possible after $E6$ was released to $V_{E6} > V_{E6, rel}$ for more than 4 μ s |

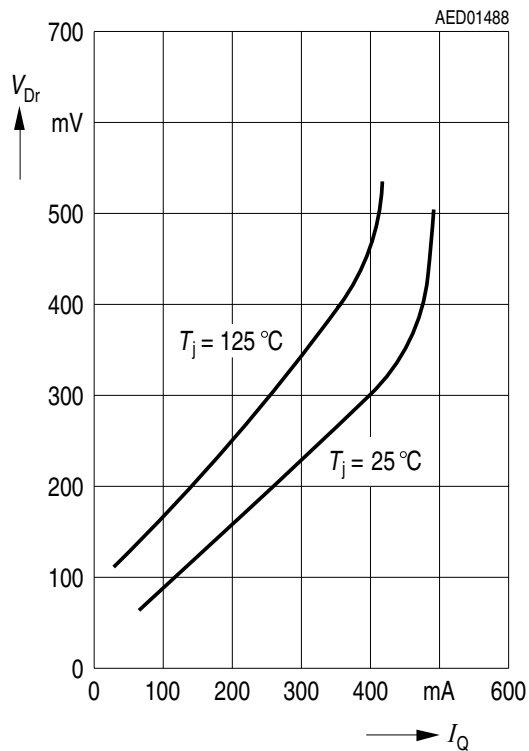
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Figure 7 Enable and Hold Behaviour

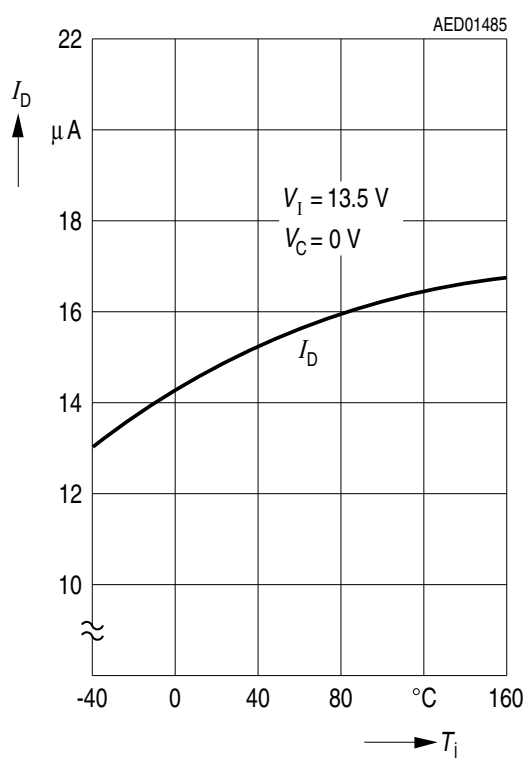
Output Voltage V_Q versus Temperature T_j



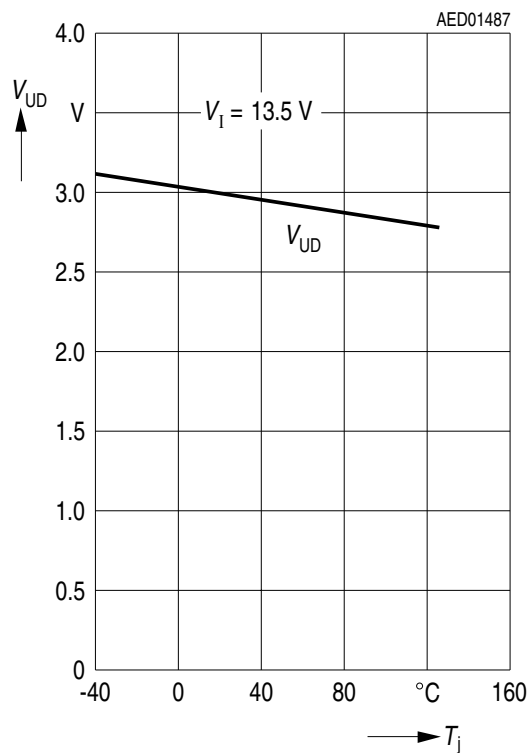
Drop Voltage V_{Dr} versus Output Current I_Q



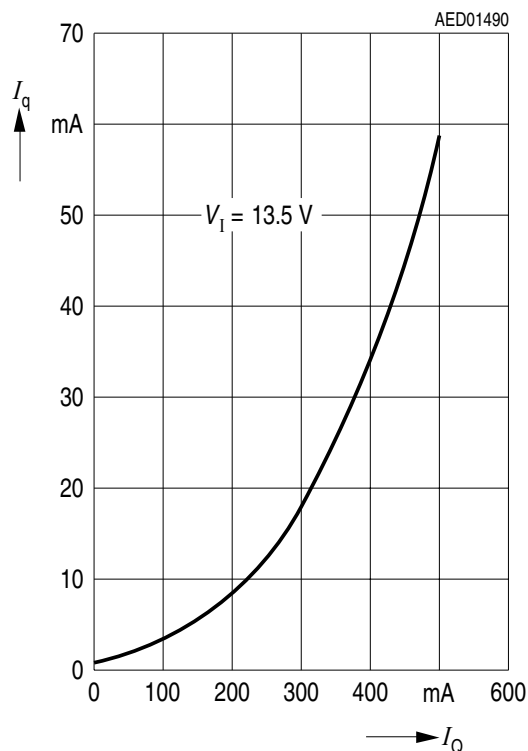
Charge Current I_D versus Temperature T_j



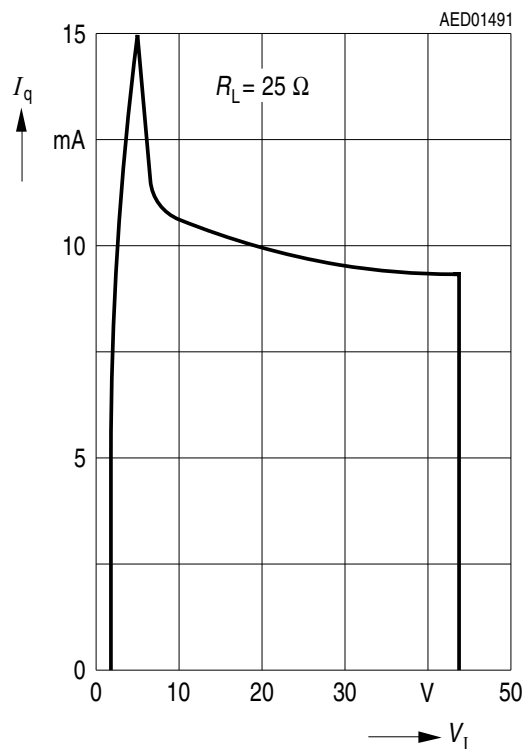
Delay Switching Threshold V_{UD} versus Temperature T_j



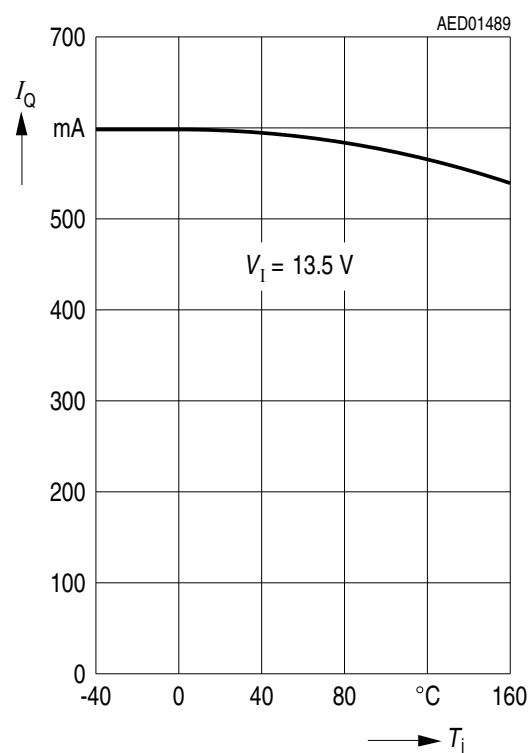
Current Consumption I_q versus Output Current I_Q



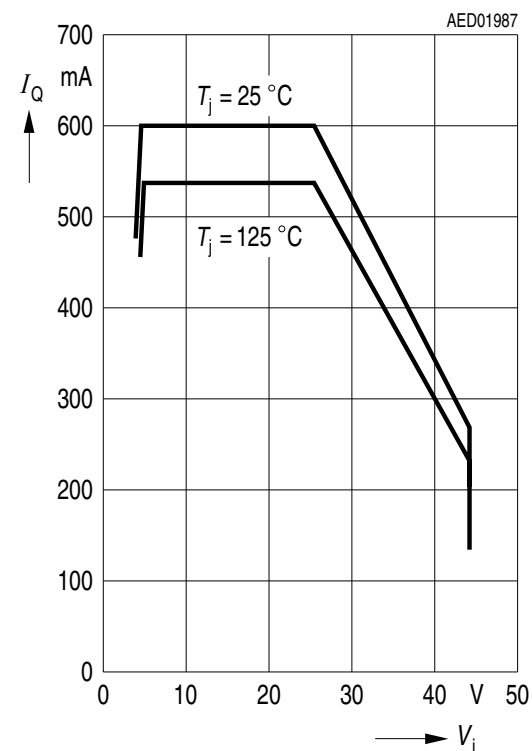
Current Consumption I_q versus Input Voltage V_I



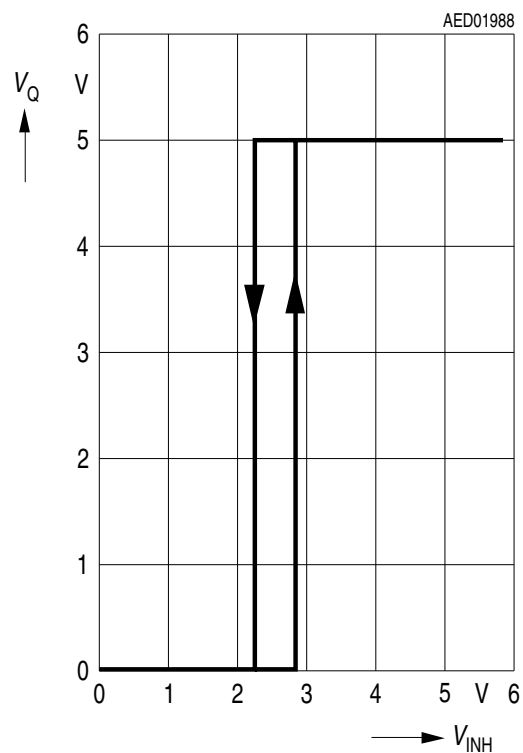
Output Current Limiting I_Q versus Temperature T_j



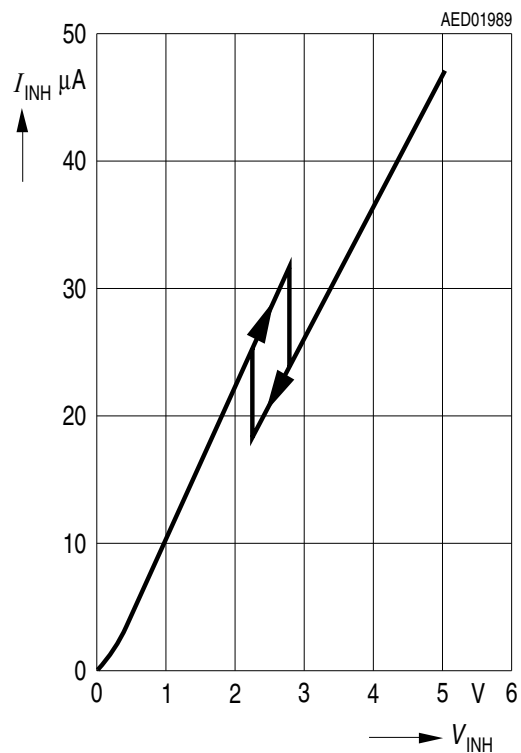
Output Current Limiting I_Q versus Input Voltage V_I



**Output Voltage V_Q versus
Inhibit Voltage V_{INH}**



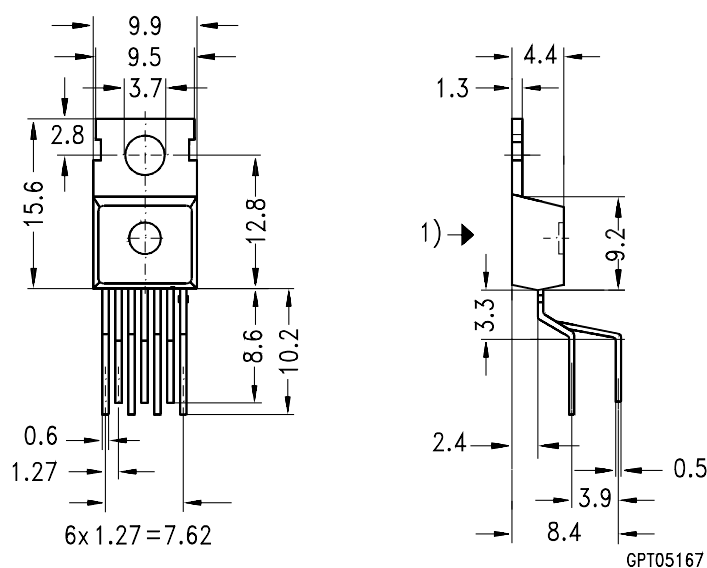
**Inhibit Current I_{INH} versus
Inhibit Voltage V_{INH}**



Package Outlines

P-TO220-7-3

(Plastic Transistor Single Outline)



Sorts of Packing

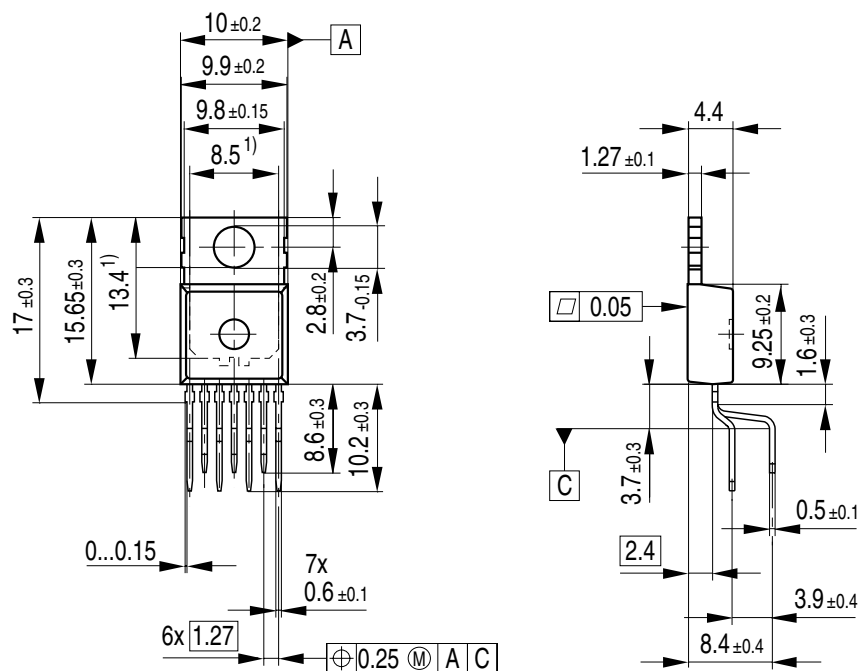
Package outlines for tubes, trays etc. are contained in our Data Book "Package Information"

Dimensions in mm

Package Outlines

P-TO220-7-11

(Plastic Transistor Single Outline)



¹⁾ Typical

All metal surfaces tin plated, except area of cut.

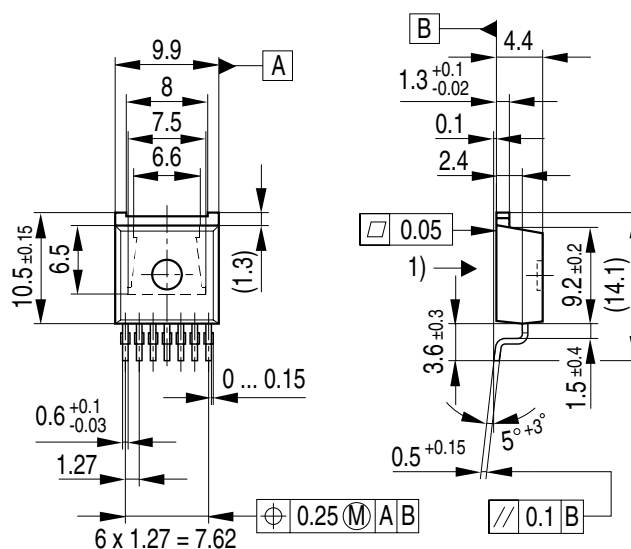
Sorts of Packing

Package outlines for tubes, trays etc. are contained in our Data Book "Package Information"

Dimensions in mm

P-TO220-7-180

(Plastic Transistor Single Outline)



1) Shear and punch direction no burrs this surface

--- Back side, heatsink contour

All metal surfaces tin plated, except area of cut

GPT05754

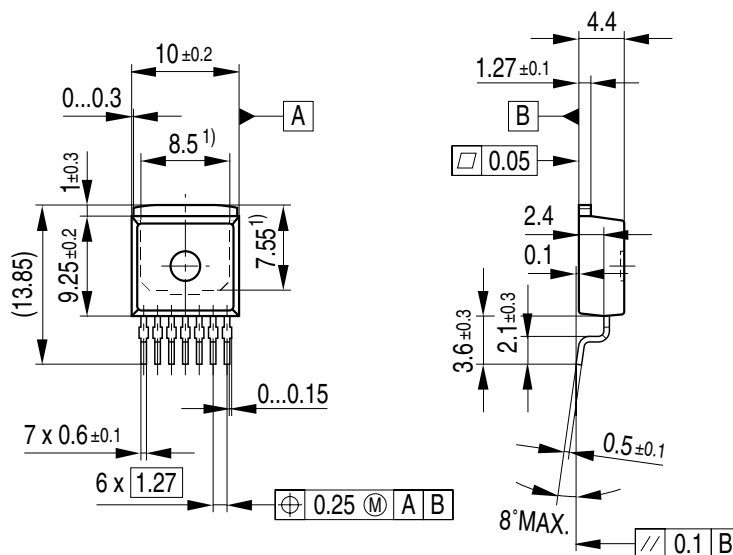
Sorts of Packing

Package outlines for tubes, trays etc. are contained in our Data Book "Package Information"

SMD = Surface Mounted Device

Dimensions in mm

P-TO220-7-4 (Plastic Transistor Single Outline)



1) Typical
Metal surface min. X = 7.25, Y = 6.9
All metal surfaces tin plated, except area of cut.

GPT05754

Sorts of Packing

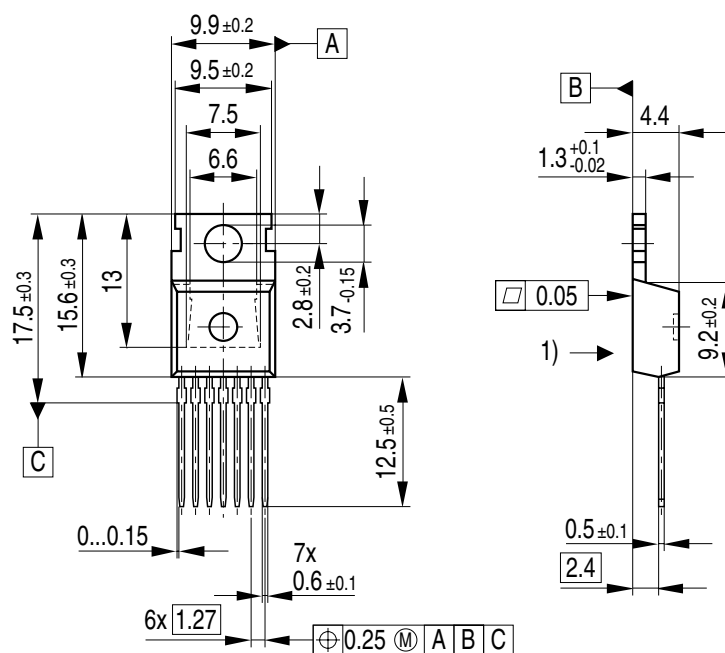
Package outlines for tubes, trays etc. are contained in our Data Book "Package Information"

SMD = Surface Mounted Device

Dimensions in mm

P-TO220-7-230

(Plastic Transistor Single Outline)



- 1) Shear and punch direction no burrs this surface.
---- Back side, heatsink contour
All metal surfaces tin plated, except area of cut.

GPT05887

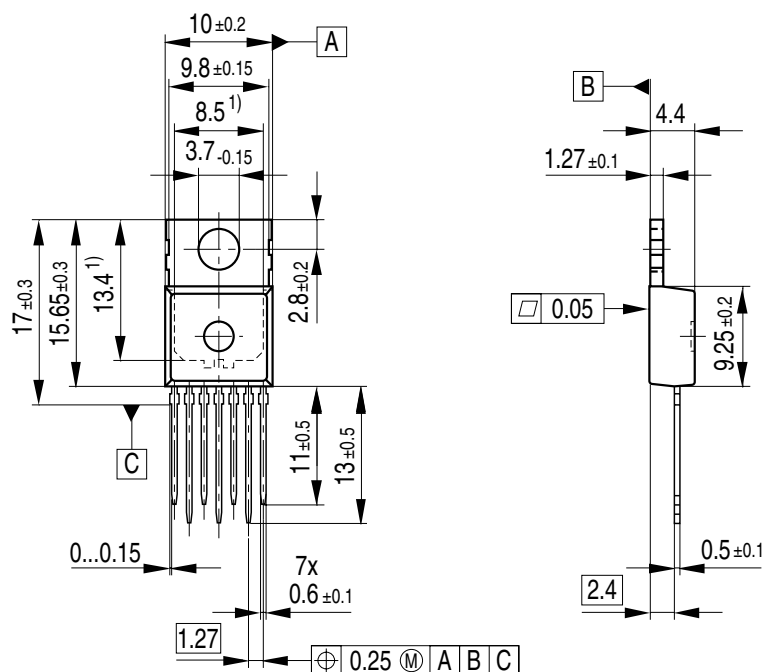
Sorts of Packing

Package outlines for tubes, trays etc. are contained in our Data Book "Package Information"

Dimensions in mm

P-TO220-7-12

(Plastic Transistor Single Outline)



¹⁾ Typical

All metal surfaces tin plated, except area of cut.

GPT09084

GPT05887

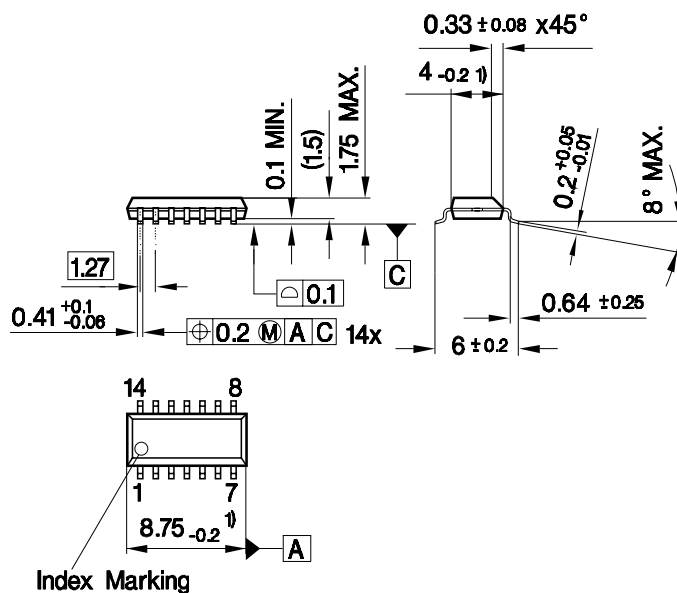
Sorts of Packing

Package outlines for tubes, trays etc. are contained in our Data Book "Package Information"

Dimensions in mm

P-DSO-14-8

(Plastic Dual Small Outline)



1) Does not include plastic or metal protrusion of 0.15 max. per side

GPS09222

Sorts of Packing

Package outlines for tubes, trays etc. are contained in our Data Book "Package Information"

SMD = Surface Mounted Device

Dimensions in mm

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